

In the Claims:

This listing of claims replaces all prior versions.

1.- 3. (Cancelled)

4. (Currently amended) A device according to claim 3 comprising: a power insulated gate field effect transistor, having main cells controlled by a main cell insulated gate and sense cells controlled by a sense cell insulated gate; a feedback sample and hold circuit connected in series with the sense cells and arranged to operate in a plurality of states including at least one sample state and a hold state; wherein the sample and hold circuit is arranged to sense the current flowing through the sense cells when in the at least one sample state but not in the hold state,

wherein the sample and hold circuit is arranged to operate in the sample state to sense the current passing through the sense cells and having an output arranged to drive the sense cell gate towards a voltage in which a target current passes through the sense cells, and to operate in the hold state to hold its output voltage and to drive the main cell insulated gate with that output voltage, and

wherein the output of the feedback sample and hold circuit is connected to a gate drive node connected to the sense cell insulated gate and connected to the main cell insulated gate through a first switch, the first switch being held open in the sample state to isolate the main cell insulated gate from the gate drive node and closed in the hold state to drive the main cell insulated gate from the gate drive nodes, and

wherein the feedback sample and hold circuit ~~include~~ comprises: a sample and hold voltage amplifier connected to drive the gate drive node; an input summing node connected to the input of the voltage amplifier; a current supply supplying a reference current to the input summing nodes; and a current mirror circuit connected to the input summing node, the current mirror circuit being arranged in the sample state to pass a mirror current from the input summing node mirroring the current passing through the sense cells; wherein the current mirror circuit and sample and hold voltage amplifier are arranged to act in the sample state as a feedback loop to tend to drive the gate drive node

towards a voltage in which a target current matching the reference current passes through the sense cells.

5. (Previously Presented) A device according to claim 4 comprising: source and drain output terminals, the main cells being connected between the source and drain output terminals; and a second switch connected between the sense cells and one of the source or drain output terminals, the circuit being arranged to open the second switch in the sample mode and close the second switch in the hold state to provide a current path for current passing through the sense cells in the hold mode that does not pass through the current mirror circuit.
6. (Previously Presented) A device according to claim 4 wherein the current mirror includes: a mirror summing node connected to the source of the sense cells; a current sink field effect transistor (FET) connected to the mirror summing node to sink the current passing through the sense cells in the sample state; a summing node amplifier with an amplifier input connected to the mirror summing node and an amplifier output connected to the gate of the current sink FET through a third switch, the third switch being closed in the or each sample state; a current mirror FET mirroring the current sink FET, the output of the summing node amplifier connecting to the gate of the current mirror FET to control the current mirror FET to mirror the current passing through the current sink FET.
7. (Previously Presented) A device according to claim 6 further comprising a fourth switch connected to the gate of the current sink FET to switch off the current sink FET in the hold mode.
8. (Previously Presented) A device according to claim 6 further comprising a measurement sample and hold circuit including a measurement mirror' FET connected to the current sink FET, the measurement mirror FET being connected to a mirror current output terminal, the measurement sample and hold circuit being arranged to operate in a measurement sample state with the second switch open to mirror the current passing through the current sink FET on the measurement mirror FET.

9. (Previously Presented) A device according to claim 6 wherein the current supply is pulsed to operate only in the or each sample state; the third switch is provided between the summing node amplifier and a common node; and the gates of the mirror FET and the current sink FET are connected to the common node; the device further comprising auto-zero circuitry for zeroing the summing node amplifier during the hold state.

10. (Previously Presented) A device according to claim 9, further comprising a measurement mirror FET having a gate connected to the common node wherein the circuit is arranged to have a measurement sample state in which a second switch is open and current passing through the sense cells is mirrored on the measurement mirror FET.

11. (Currently amended) A device ~~according to claim 3~~ comprising: a power insulated gate field effect transistor, having main cells controlled by a main cell insulated gate and sense cells controlled by a sense cell insulated gate; a feedback sample and hold circuit connected in series with the sense cells and arranged to operate in a plurality of states including at least one sample state and a hold state; wherein the sample and hold circuit is arranged to sense the current flowing through the sense cells when in the at least one sample state but not in the hold state,

wherein the sample and hold circuit is arranged to operate in the sample state to sense the current passing through the sense cells and having an output arranged to drive the sense cell gate towards a voltage in which a target current passes through the sense cells, and to operate in the hold state to hold its output voltage and to drive the main cell insulated gate with that output voltage, and

wherein the output of the feedback sample and hold circuit is connected to a gate drive node connected to the sense cell insulated gate and connected to the main cell insulated gate through a first switch, the first switch being held open in the sample state to isolate the main cell insulated gate from the gate drive node and closed in the hold state to drive the main cell insulated gate from the gate drive nodes, and

further comprising a charge pumped current sink connected to the current mirror circuit to sink the current passing through the mirror.

12. (Currently amended) A device ~~according to claim 1~~ comprising: a power insulated gate field effect transistor, having main cells controlled by a main cell insulated gate and sense cells controlled by a sense cell insulated gate; a sample and hold circuit connected in series with the sense cells and arranged to operate in a plurality of states including at least one sample state and a hold state; wherein the sample and hold circuit is arranged to sense the current flowing through the sense cells when in the at least one sample state but not in the hold state, and

wherein the sample and hold circuit includes a current mirror circuit including: a mirror summing node connected to the source of the sense cells; a current sink field effect transistor (FET) connected to the summing node to sink the current passing through the sense cells in the or each sample mode; a summing node sample and hold amplifier with an amplifier input connected to the mirror summing node and an amplifier output connected to the gate of the current sink FET through a third switch, the third switch being closed in at least one sample state to control the current sink; and at least one mirror FET mirroring the current sink FET, the output of the summing node amplifier connecting to the gate of the mirror FET to control the mirror FET to mirror in the mirror FET the current passing in the current sink FET in a sample state.

13. (Previously Presented) A device according to claim 12 wherein the at least one mirror FET includes a measurement mirror FET connected to a measurement output terminal, and the at least one sample state includes a measurement sample state in which the current on the sense cells is mirrored on the measurement output terminal.

14. (Previously Presented) A device according to claim 12 wherein the at least one mirror FET includes a current mirror FET connected to a feedback sample and hold amplifier connected to drive the gate of the sense cells and connected through a first switch to drive the gate of the main cells in the hold mode.

15. (Previously Presented) A device according to claim 14 further comprising a current source sourcing current into a voltage drive node connected to an input of the feedback

sample and hold amplifiers, the voltage drive node connected through the current mirror FET to a current sink.

16.- 20. (Cancelled)